

<b>Notice of References Cited</b>	Application/Control No. 10/517,831	Applicant(s)/Patent Under Reexamination SHIRAISHI ET AL.	
	Examiner Igor Kershteyn	Art Unit 3745	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,471,470	10-2002	Yoshimura et al.	415/160
*	B	US-6,669,442	12-2003	Jinnai et al.	415/160
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
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**NON-PATENT DOCUMENTS**

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